Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/604,166	SINGH ET AL	
Examiner	Art Unit	
Tae H. Yoon	1714	

					
SEARCHED					
Class	Subclass	Date	Examiner		
524	267	1-2/-8	my		
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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